




Searched 	Application/Control No. 10525069	Applicant(s)/Patent Under Reexamination HIRAI ET AL.
	Examiner Mehrpour, Naghmeh	Art Unit 2617

Class	SubClass	Date	Examiner
455	452.2	08/28/2006	NM
	24		
	450		
	500		
	509		
	550.1		
	502		
	126		
	512		
	562.1		
	575.7		
	101		
370	330		
	335		
	336		
	342		
	343		
	441		
	442		
	252		
	278		
	328		
	329		
	337		
	347-349		
Updated		11/03/06	NM

Search Notes 	Application/Control No.	Applicant(s)/Patent Under Reexamination
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Notes	Date	Examiner
EAST	12/20/2005	NM
WEST	12/20/2005	NM
Nick Corsora 455/452.2	12/20/2005	NM
Temica Davis	12/20/2005	NM
Charles Appiah	12/20/2005	NM
Lee Nyguen 455/69	12/21/2005	NM
John Pezzlo 370/278, 328, 329, 330, 335, 336, 342, 343, 441, 442, 252	12/21/2005	NM
Inventer search in eDAN	08/28/2006	NM
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U.S. Patent and Trademark Office		Part of Paper No.: 11/06/06

Interference Searched 	Application/Control No. 10525069	Applicant(s)/Patent Under Reexamination HIRAI ET AL.
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455	69	08/28/2006	NM
370	278	08/28/2006	NM
See attachment for interference search		11/06/06	NM
U.S. Patent and Trademark Office		Part of Paper No.:	11/06/06